



Ge/Si APD for PAM4 application

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SiFotonics



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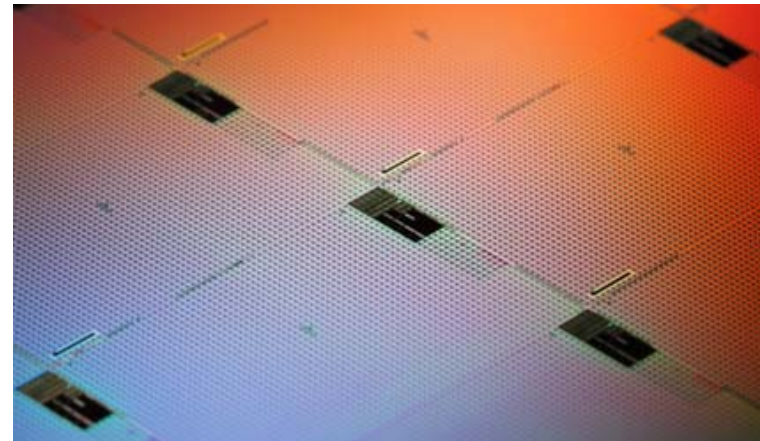


New Platform of Ge/Si for photonic devices

Ge/Si devices are manufactured by standard CMOS commercial foundry (130nm node), and the process of Ge growth on Si is completed on 8-inch CVD



SiFotonics's CVD tool in Commercial CMOS foundry

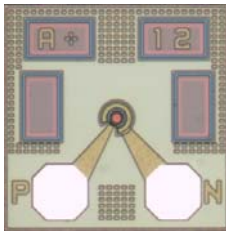


SiFotonics's 200nm SOI wafer

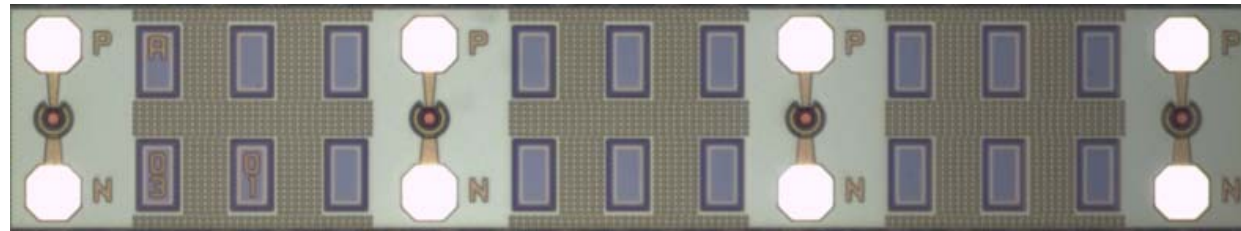


Ge/Si APD advantage

- Ge/Si APDs cover both 1310nm and 850nm applications;
- Ge/Si APDs can provide 5~6dB more link budget than PIN solution, which can reduce power of Tx output power or provide more Rx sensitivity margin;
- Ge/Si APDs are using silicon photonics technologies and are fabricated at CMOS foundry;
- Both single 25G Ge/Si APD and 4x25G Ge/Si APD array are ready for mass production;



OM image of Ge/Si APD

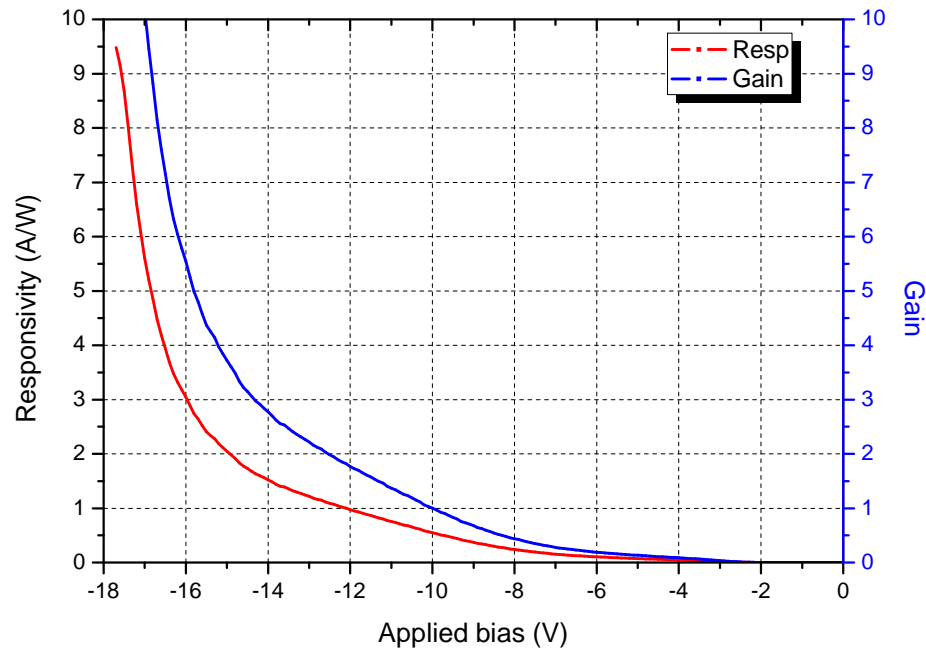


OM image of Ge/Si APD array



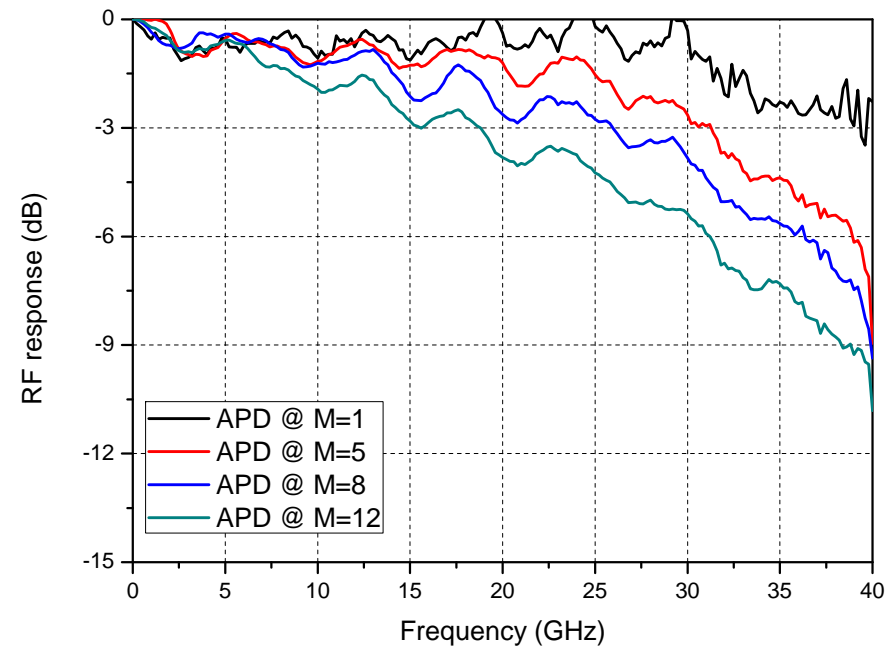
Ge/Si APD device DC & RF performance

1310nm Responsivity & gain curves



Test equipment: Agilent 4145B semiconductor parameter analyzer
Test conditions: room temperature, 1310nm, input optical power = -13dBm

S21 curve at different APD gains

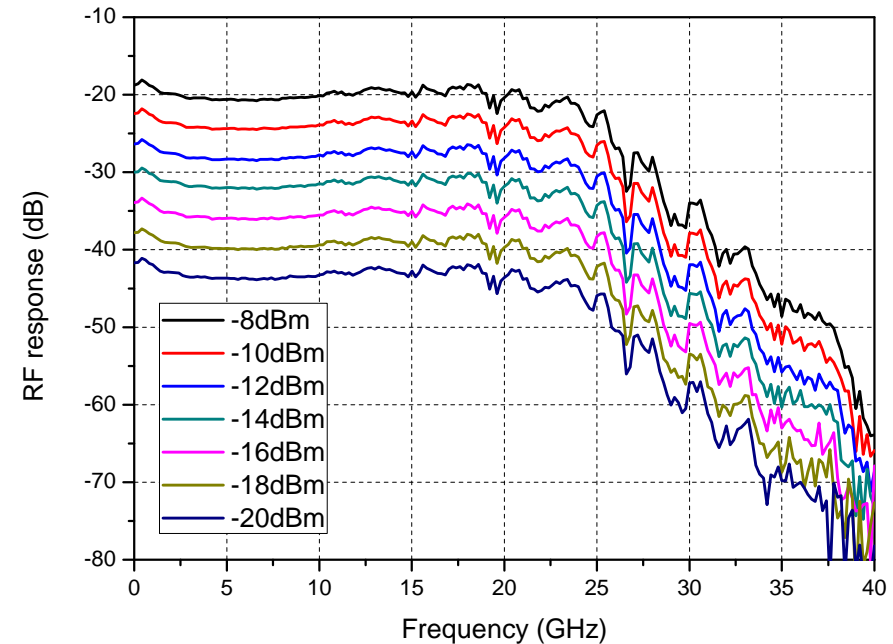
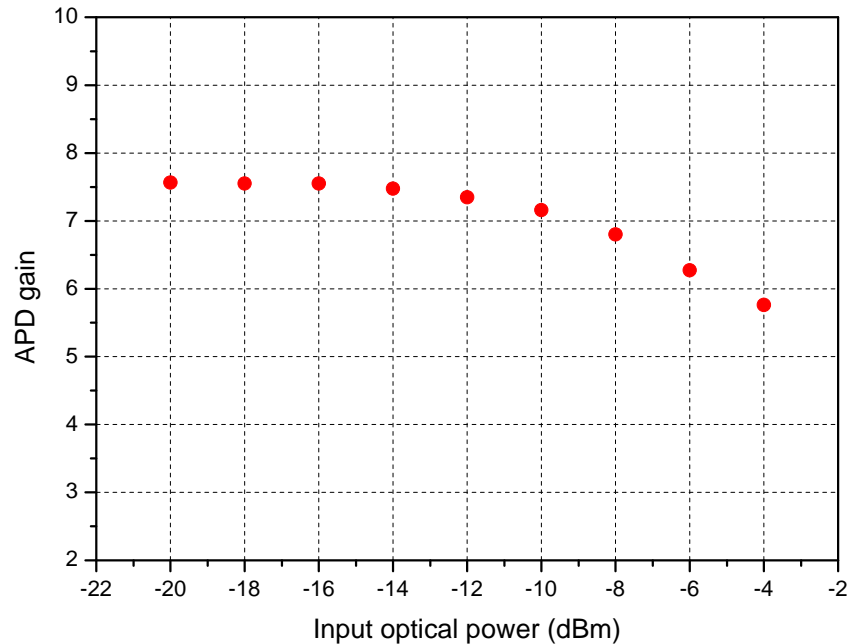


Test equipment: Anritsu MS46122A Network Analyzer
Test conditions: laser + external LiNbO3 modulator; input optical power = -13dBm, room temperature



High linear Ge/Si APD based receiver performance

This linear receiver is composed by a Ge/Si APD and a 32G linear TIA.

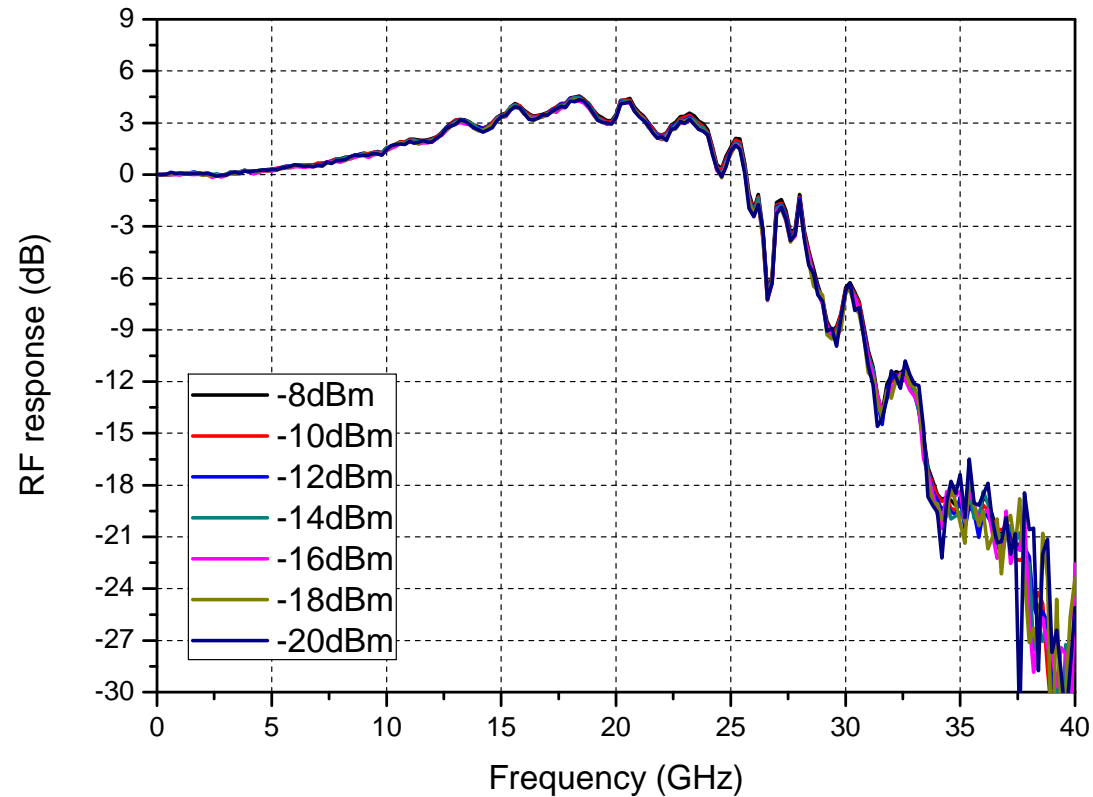


Test conditions: 1310nm, APD bias at $V_{br}-1.5$, room temperature

Under a large optical power range (-20~-8dBm) and APD is biased at operation condition ($V_{br}-1.5$), the receiver's gain and S21 curves are almost unchanged, which demonstrate great linearity of this Ge/Si APD based receiver.



Linear receiver S21 curves (normalized)

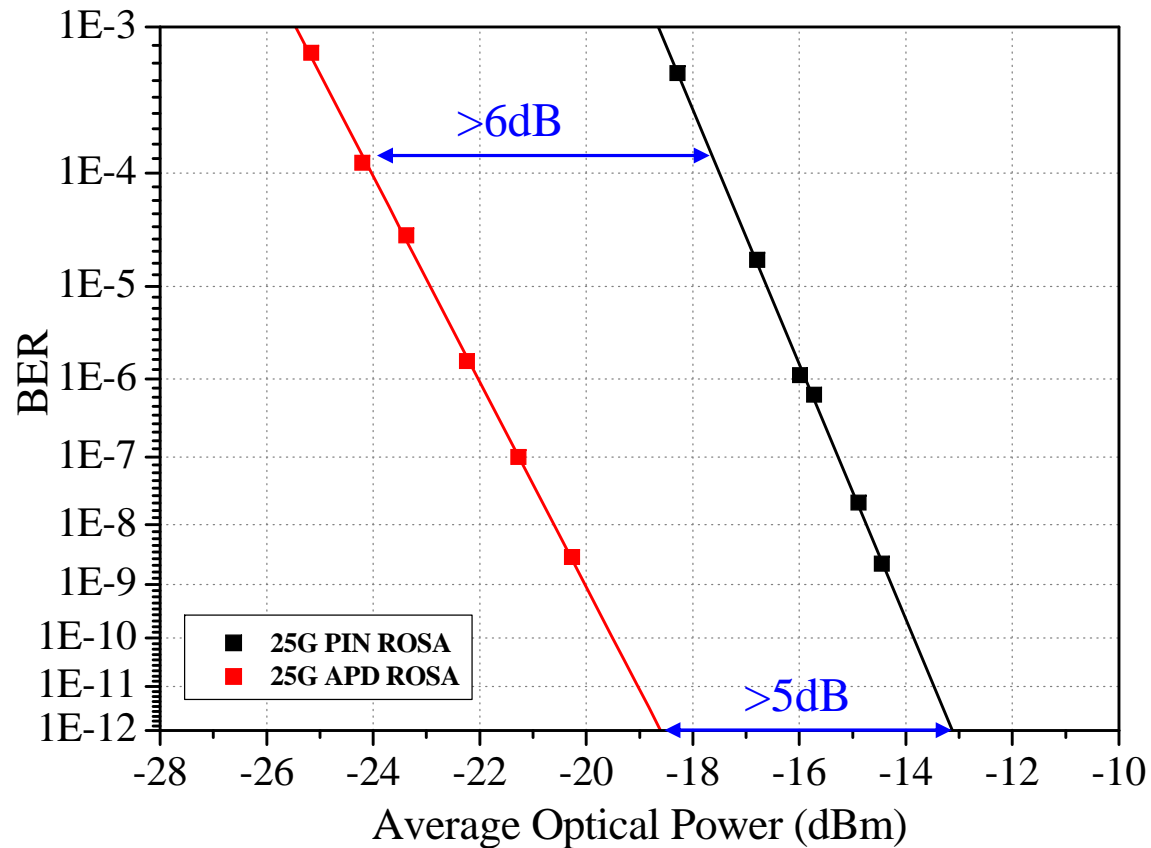


Test conditions: 1310nm, APD bias at $V_{br}-1.5$, APD gain=7.5 (@-20dBm), room temperature

Normalized 3-dB bandwidth of this receiver is close to 28GHz, this value could be further improved to >30GHz by optimized bonding scheme.



APD & PIN ROSA sensitivity comparison (using 25G limiting TIA)



Test conditions: 25.78Gb/s, 1310nm, ER=7dB, PRBS=2³¹-1, NRZ, room temperature